#### **SCOPE:**

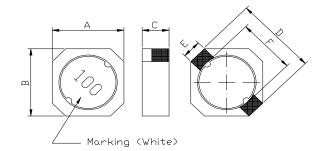
This specification applies to the Pb Free high current type SMD inductors for MSCDRI-5020F-SERIES

#### PRODUCT INDENTIFICATION

#### MSCDRI-5020F-100 M

- (1)
- 2
- 3 4
- **1** Product Code
- **② Dimensions Code**
- **3 Inductance Code**
- **4** Tolerance Code

#### (1) SHAPES AND DIMENSIONS



A: 5.30Max. mm

B: 5.30Max. mm

C: 2.00Max. mm

D: 5.80±0.3 mm

E: 1.70Typ. mm

F: 4.20Typ. mm

# (2) ELECTRICAL SPECIFICATIONS SEE TABLE 1

**TEST INSTRUMENTS** 

L : HP 4284A PRECISION LCR METER (or equivalent)

RDC: CHROMA MODEL 16502 MILLIOHMMETER (or equivalent)

## (3) CHARACTERISTICS

(3)-1 Ambient temperature ...... +60°C Max.

(3)-2 Operate temperature range ......  $-40^{\circ}\text{C} \sim +125^{\circ}\text{C}$ 

(Including self temp. rise)

(3)-3 Storage temperature range ......  $-40^{\circ}$ C  $\sim +125^{\circ}$ C



#### **TABLE 1**

MACLAYERS								
MAGLAYERS	Inductance	Percent	Test	Resistance	Rated DC Current		Marking	
PT/NO.	L(µH)	Tolerance	Frequency	RDC(Ω)Max.	IDC1(A)	IDC2(A)	mar King	
MSCDRI-5020F-1R2□	1.2	N	100kHz,025V	44m	2.15	2.87	1R2	
MSCDRI-5020F-2R2□	2.2	N	100kHz,025V	59m	1.63	2.06	2R2	
MSCDRI-5020F-3R5□	3.5	N	100kHz,025V	73m	1.34	1.82	3R5	
MSCDRI-5020F-4R7□	4.7	M,N	100kHz,025V	87m	1.14	1.54	4R7	
MSCDRI-5020F-6R8□	6.8	N	100kHz,025V	0.105	0.95	1.38	6R8	
MSCDRI-5020F-100□	10	M,N	100kHz,025V	0.150	0.76	1.10	100	
MSCDRI-5020F-150	15	M,N	100kHz,025V	0.210	0.63	0.91	150	
MSCDRI-5020F-220	22	M,N	100kHz,025V	0.275	0.56	0.83	220	
MSCDRI-5020F-330	33	M,N	100kHz,025V	0.455	0.44	0.61	330	
MSCDRI-5020F-470	47	M,N	100kHz,025V	0.730	0.36	0.45	470	
MSCDRI-5020F-680	68	M,N	100kHz,025V	0.935	0.30	0.42	680	
MSCDRI-5020F-101	100	M,N	100kHz,025V	1.500	0.23	0.31	101	

**※** ☐ specify the inductance tolerance,M(±20%),N(±30%)

※ IDC1: Based on inductance change (△L/Lo: drop 30% max)

IDC2 : Based on temperature rise ( $\triangle T$ : 40°C TYP.) Rated DC Current : The less value which is IDC1 or IDC2.



# (4) RELIABILITY TEST METHOD MECHANICAL

TEST ITEM	SPECIFICATION	TEST DETAILS		
Substrate bending	∆L/Lo≦±5%	The sample shall be soldered onto the printed circuit board		
		in figure 1 and a load applied unitil the figure in the arrow		
	There shall be	direction is made approximately 3mm.(keep time 30 seconds)		
	no mechanical	PCB dimension shall the page 7/9		
	damage or elec-	F(Pressurization)		
	trical damege.	$\Box$		
		R5 45±2 45±2 10 20		
		R340		
		PRESSURE ROD		
		figure-1		
Vibration	∆L/Lo≦±5%	The sample shall be soldered onto the printed circuit board		
		and when a vibration having an amplitude of 1.52mm		
	There shall be	and a frequency of from 10 to 55Hz/1 minute repeated should		
	no mechanical	be applied to the 3 directions (X,Y,Z) for 2 hours each.		
	damage.	(A total of 6 hours)		
Solderability	New solder	Flux (rosin, isopropyl alcohol{JIS-K-1522}) shall be coated		
	More than 90%	over the whole of the sample before hard, the sample shall		
		then be preheated for about 2 minutes in a temperature of		
		130~150°C and after it has been immersed to a depth 0.5mm		
		below for 3±0.2 seconds fully in molten solder M705 with		
		a temperature of 245±5℃.		
		More than 90% of the electrode sections shall be couered		
		with new solder smoothly when the sample is taken out of		
		the solder bath.		

#### **MECHANICAL**

TEST ITEM	SPECIFICATION						
TEST ITEM  Resistance to  Soldering heat (reflow soldering)	There shall be no damage or problems.	SPECIFICATION  Temperature profile of reflow soldering  soldering  (Peak temperature 260±3°C 10 sec  150  Pre-heating  Slow cooling (Stored at room temperature)					
		The specimen shall be passed through the reflow oven with the condition shown in the above profile for 1 time.  The specimen shall be stored at standard atmospheric conditions for 1 hour, after which the measurement shall be made.					

## **ELECTRICAL**

TEST ITEM	SPECIFICATION	TEST DETAILS		
Insulation	There shall be	DC 100V voltage shall be applied across this sample of top		
resistance	no other	surface and the terminal.		
	damage or	The insulation resistance shall be more than $1 \times 10^8 \Omega$ .		
	problems.			
Dielectric	There shall be	AC 100V voltage shall be applied for 1 minute acrosset the top		
withstand	no other	surface and the terminal of this sample		
voltage	damage or			
	problems.			
Temperature	∆L/L20°C ≦±10%	The test shall be performed after the sample has stabilized in		
characteristics	0~2000 ppm/℃	an ambient temperature of -20 to +85 $^{\circ}\mathrm{C}$ ,and the value		
		calculated based on the value applicable in a normal		
		temperature and narmal humidity shall be △L/L20℃ ≦±10%.		



## **ENVIROMENT CHARACTERISTICS**

TEST ITEM				SPECIFICATION				
High temperature	∆L/Lo≦±5%	The samp	The sample shall be left for 96±4 hours in an atmospere with					
storage		a tempera	a temperature of 85±2℃ and a normal humidity.					
	There shall be	here shall be Upon completion of the measurement shall be made after the						
	no mechanical	sample ha	sample has been left in a normal temperature and normal					
	damage.	humidity f	humidity for 1 hour.					
Low temperature	∆L/Lo≦±5%	The samp	The sample shall be left for 96±4 hours in an atmosphere with					
storage		a temperature of -25±3℃.						
	There shall be	Upon com	Upon completion of the test, the measurement shall be made					
	no mechanical	after the s	after the sample has been left in a normal temperature and					
	damage.	normal hu	normal humidity for 1 hour.					
Change of	∆L/Lo≦±5%	The samp	The sample shall be subject to 5 continuos cycles, such as shown					
temperature		in the tabl	in the table 2 below and then it shall be subjected to standard					
	There shall be	stmosphe	stmospheric conditions for 1 hour, after which measurement					
	no other dama-	shall be m	shall be made.					
	ge of problems							
		table 2						
				Temperature	Duration			
			1	<b>-25±3</b> ℃	30 min.			
				(Themostat No.1)				
			2	Standard	No.1→No.2			
				atmospheric	NO.1→NO.2			
			3	85±2℃	30 min.			
			-	(Themostat No.2)	00			
			4	Standard	No.2→No.1			
				atmospheric	NO.2→NO.1			
Moisture storage	∆L/Lo≦±5%	The same	ء ما	hall be left for 96+4 hour	rs in a temperature of			
moisiuie siviaye	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	•	The sample shall be left for 96±4 hours in a temperature of					
	There shall be	40±2℃ and a humidity(RH) of 90~95%.  Upon completion of the test, the measurement shall be made						
	no mechanical	after the sample has been left in a normal temperature and						
	damage.	normal humidity more than 1 hour.						
Test conditions :	uamaye.	normai nu	411110	my more man i nour.				
			_	the printed circuit board				

The sample shall be reflow soldered onto the printed circuit board in every test.

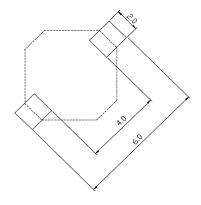


# (5) LAND DIMENSION (Ref.)

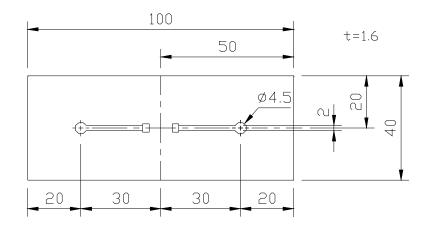
PCB: GLASS EPOXY t=1.6mm

## (5)-1 LAND PATTERN DIMENSIONS

(STANDARD PATTERN)

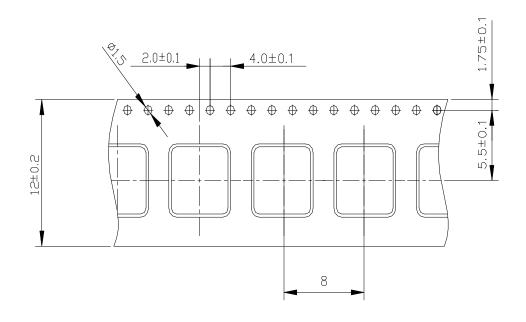


## (5)-2 SUBSTRATE BENDING TEST BENDING TEST BOARD



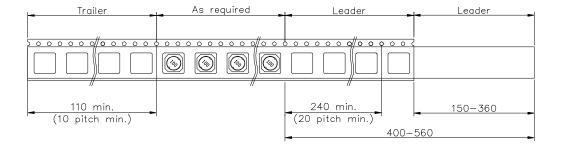
# (6) PACKAGING

## (6)-1 CARRIER TAPE DIMENSIONS (mm)

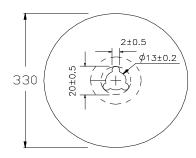


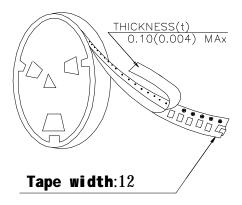
## (6)-2 TAPING DIMENSIONS (mm)





# (6)-3 REEL DIMENSIONS (mm)





## (6)-4 QUANTITY

3500pcs/Reel

The products are packaged so that no damage will be sustained.